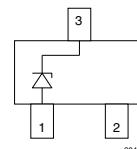
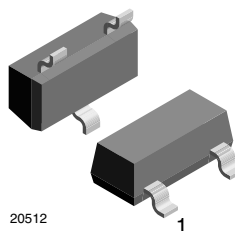


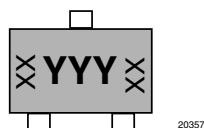
## Single-Line ESD-Protection in SOT23

### Features

- Single-line ESD-protection device
- ESD-immunity acc. IEC 61000-4-2
  - ± 30 kV contact discharge
  - ± 30 kV air discharge
- Space saving SOT23 package
- Lead (Pb)-free component
- Lead finish = "e3" = matte tin (Sn)
- Component in accordance to RoHS 2002/95/EC and WEEE 2002/96/EC



### Marking (example only)



YYY = Type code (see table below)  
XX = Date code

### Ordering Information

Device name	Ordering code	Taped units per reel (8 mm tape on 7" reel)	Minimum order quantity
GSOT03	GSOT03-GS08	3000	15000
GSOT04	GSOT04-GS08	3000	15000
GSOT05	GSOT05-GS08	3000	15000
GSOT08	GSOT08-GS08	3000	15000
GSOT12	GSOT12-GS08	3000	15000
GSOT15	GSOT15-GS08	3000	15000
GSOT24	GSOT24-GS08	3000	15000
GSOT36	GSOT36-GS08	3000	15000

### Package Data

Device name	Package name	Marking code	Weight	Molding compound flammability rating	Moisture sensitivity level	Soldering conditions
GSOT03	SOT23	03	8.8 mg	UL 94 V-0	MSL level 1 (according J-STD-020)	260 °C/10 s at terminals
GSOT04	SOT23	04	8.8 mg	UL 94 V-0	MSL level 1 (according J-STD-020)	260 °C/10 s at terminals
GSOT05	SOT23	05	8.8 mg	UL 94 V-0	MSL level 1 (according J-STD-020)	260 °C/10 s at terminals
GSOT08	SOT23	08	8.8 mg	UL 94 V-0	MSL level 1 (according J-STD-020)	260 °C/10 s at terminals
GSOT12	SOT23	12	8.8 mg	UL 94 V-0	MSL level 1 (according J-STD-020)	260 °C/10 s at terminals
GSOT15	SOT23	15	8.8 mg	UL 94 V-0	MSL level 1 (according J-STD-020)	260 °C/10 s at terminals
GSOT24	SOT23	24	8.8 mg	UL 94 V-0	MSL level 1 (according J-STD-020)	260 °C/10 s at terminals
GSOT36	SOT23	36	8.8 mg	UL 94 V-0	MSL level 1 (according J-STD-020)	260 °C/10 s at terminals

## Absolute Maximum Ratings

### GSOT03

Rating	Test condition	Symbol	Value	Unit
Peak pulse current	Pin 3 to 1 Acc. IEC 61000-4-5, $t_p = 8/20 \mu s$ ; single shot	$I_{PPM}$	30	A
Peak pulse power	Pin 3 to 1 Acc. IEC 61000-4-5, $t_p = 8/20 \mu s$ ; single shot	$P_{PP}$	369	W
ESD immunity	Contact discharge acc. IEC 61000-4-2; 10 pulses	$V_{ESD}$	$\pm 30$	kV
	Air discharge acc. IEC 61000-4-2; 10 pulses	$V_{ESD}$	$\pm 30$	kV
Operating temperature	Junction temperature	$T_J$	- 40 to + 125	°C
Storage temperature		$T_{STG}$	- 55 to + 150	°C

### GSOT04

Rating	Test condition	Symbol	Value	Unit
Peak pulse current	Pin 3 to 1 Acc. IEC 61000-4-5, $t_p = 8/20 \mu s$ ; single shot	$I_{PPM}$	30	A
Peak pulse power	Pin 3 to 1 Acc. IEC 61000-4-5, $t_p = 8/20 \mu s$ ; single shot	$P_{PP}$	429	W
ESD immunity	Contact discharge acc. IEC 61000-4-2; 10 pulses	$V_{ESD}$	$\pm 30$	kV
	Air discharge acc. IEC 61000-4-2; 10 pulses	$V_{ESD}$	$\pm 30$	kV
Operating temperature	Junction temperature	$T_J$	- 40 to + 125	°C
Storage temperature		$T_{STG}$	- 55 to + 150	°C

### GSOT05

Rating	Test condition	Symbol	Value	Unit
Peak pulse current	Pin 3 to 1 Acc. IEC 61000-4-5, $t_p = 8/20 \mu s$ ; single shot	$I_{PPM}$	30	A
Peak pulse power	Pin 3 to 1 Acc. IEC 61000-4-5, $t_p = 8/20 \mu s$ ; single shot	$P_{PP}$	480	W
ESD immunity	Contact discharge acc. IEC 61000-4-2; 10 pulses	$V_{ESD}$	$\pm 30$	kV
	Air discharge acc. IEC 61000-4-2; 10 pulses	$V_{ESD}$	$\pm 30$	kV
Operating temperature	Junction temperature	$T_J$	- 40 to + 125	°C
Storage temperature		$T_{STG}$	- 55 to + 150	°C

### GSOT08

Rating	Test condition	Symbol	Value	Unit
Peak pulse current	Pin 3 to 1 Acc. IEC 61000-4-5, $t_p = 8/20 \mu s$ ; single shot	$I_{PPM}$	18	A
Peak pulse power	Pin 3 to 1 Acc. IEC 61000-4-5, $t_p = 8/20 \mu s$ ; single shot	$P_{PP}$	345	W
ESD immunity	Contact discharge acc. IEC 61000-4-2; 10 pulses	$V_{ESD}$	$\pm 30$	kV
	Air discharge acc. IEC 61000-4-2; 10 pulses	$V_{ESD}$	$\pm 30$	kV
Operating temperature	Junction temperature	$T_J$	- 40 to + 125	°C
Storage temperature		$T_{STG}$	- 55 to + 150	°C



## GSOT12

Rating	Test condition	Symbol	Value	Unit
Peak pulse current	Pin 3 to 1 Acc. IEC 61000-4-5, $t_p = 8/20 \mu s$ ; single shot	$I_{PPM}$	12	A
Peak pulse power	Pin 3 to 1 Acc. IEC 61000-4-5, $t_p = 8/20 \mu s$ ; single shot	$P_{PP}$	312	W
ESD immunity	Contact discharge acc. IEC 61000-4-2; 10 pulses	$V_{ESD}$	$\pm 30$	kV
	Air discharge acc. IEC 61000-4-2; 10 pulses	$V_{ESD}$	$\pm 30$	kV
Operating temperature	Junction temperature	$T_J$	- 40 to + 125	°C
Storage temperature		$T_{STG}$	- 55 to + 150	°C

## GSOT15

Rating	Test condition	Symbol	Value	Unit
Peak pulse current	Pin 3 to 1 Acc. IEC 61000-4-5, $t_p = 8/20 \mu s$ ; single shot	$I_{PPM}$	8	A
Peak pulse power	Pin 3 to 1 Acc. IEC 61000-4-5, $t_p = 8/20 \mu s$ ; single shot	$P_{PP}$	230	W
ESD immunity	Contact discharge acc. IEC 61000-4-2; 10 pulses	$V_{ESD}$	$\pm 30$	kV
	Air discharge acc. IEC 61000-4-2; 10 pulses	$V_{ESD}$	$\pm 30$	kV
Operating temperature	Junction temperature	$T_J$	- 40 to + 125	°C
Storage temperature		$T_{STG}$	- 55 to + 150	°C

## GSOT24

Rating	Test condition	Symbol	Value	Unit
Peak pulse current	Pin 3 to 1 Acc. IEC 61000-4-5, $t_p = 8/20 \mu s$ ; single shot	$I_{PPM}$	5	A
Peak pulse power	Pin 3 to 1 Acc. IEC 61000-4-5, $t_p = 8/20 \mu s$ ; single shot	$P_{PP}$	235	W
ESD immunity	Contact discharge acc. IEC 61000-4-2; 10 pulses	$V_{ESD}$	$\pm 30$	kV
	Air discharge acc. IEC 61000-4-2; 10 pulses	$V_{ESD}$	$\pm 30$	kV
Operating temperature	Junction temperature	$T_J$	- 40 to + 125	°C
Storage temperature		$T_{STG}$	- 55 to + 150	°C

## GSOT36

Rating	Test condition	Symbol	Value	Unit
Peak pulse current	Pin 3 to 1 Acc. IEC 61000-4-5, $t_p = 8/20 \mu s$ ; single shot	$I_{PPM}$	3.5	A
Peak pulse power	Pin 3 to 1 Acc. IEC 61000-4-5, $t_p = 8/20 \mu s$ ; single shot	$P_{PP}$	248	W
ESD immunity	Contact discharge acc. IEC 61000-4-2; 10 pulses	$V_{ESD}$	$\pm 30$	kV
	Air discharge acc. IEC 61000-4-2; 10 pulses	$V_{ESD}$	$\pm 30$	kV
Operating temperature	Junction temperature	$T_J$	- 40 to + 125	°C
Storage temperature		$T_{STG}$	- 55 to + 150	°C

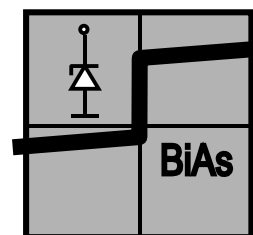
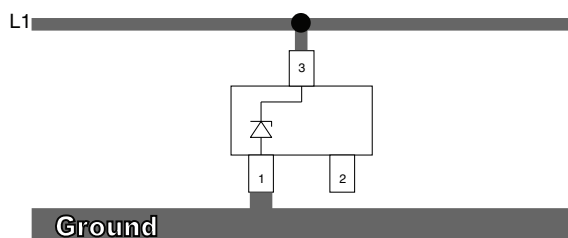
## BiAs-Mode (1-line Bidirectional Asymmetrical protection mode)

With the **GSOTxx** one signal- or data-lines (L1) can be protected against voltage transients. With pin 1 connected to ground and pin 3 connected to a signal- or data-line which has to be protected. As long as the voltage level on the data- or signal-line is between 0 V (ground level) and the specified **Maximum Reverse Working Voltage** ( $V_{RWM}$ ) the protection diode between pin 2 and pin 3 offer a high isolation to the ground line. The protection device behaves like an open switch.

As soon as any positive transient voltage signal exceeds the break through voltage level of the protection diode, the diode becomes conductive and shorts the transient current to ground. Now the protection device behaves like a closed switch. The **Clamping Voltage** ( $V_C$ ) is defined by the **Breakthrough Voltage** ( $V_{BR}$ ) level plus the voltage drop at the series impedance (resistance and inductance) of the protection device.

Any negative transient signal will be clamped accordingly. The negative transient current is flowing in the forward direction of the protection diode. The low **Forward Voltage** ( $V_F$ ) clamps the negative transient close to the ground level.

Due to the different clamping levels in forward and reverse direction the **GSOTxx** clamping behaviour is **Bidirectional** and **Asymmetrical (BiAs)**.



20422

## Electrical Characteristics

Ratings at 25 °C ambient temperature unless otherwise specified

### GSOT03

BiAs mode (between pin 3 to 1)

Parameter	Test conditions/remarks	Symbol	Min.	Typ.	Max.	Unit
Protection paths	Number of lines which can be protected	$N_{lines}$			1	lines
Reverse stand off voltage	at $I_R = 100 \mu A$	$V_{RWM}$	3.3			V
Reverse current	at $V_R = 3.3 V$	$I_R$			100	$\mu A$
Reverse break down voltage	at $I_R = 1 mA$	$V_{BR}$	4	4.6		V
Reverse clamping voltage	at $I_{PP} = 1 A$	$V_C$		5.7	7.5	V
	at $I_{PP} = I_{PPM} = 30 A$	$V_C$		10	12.3	V
Forward clamping voltage	at $I_{PP} = 1 A$	$V_F$		1	1.2	V
	at $I_{PP} = I_{PPM} = 30 A$	$V_F$		4.5		V
Capacitance	at $V_R = 0 V$ ; $f = 1 MHz$	$C_D$		420	600	pF
	at $V_R = 1.6 V$ ; $f = 1 MHz$	$C_D$		260		pF

## GSOT04

BiAs mode (between pin 3 to 1)

Parameter	Test conditions/remarks	Symbol	Min.	Typ.	Max.	Unit
Protection paths	Number of lines which can be protected	$N_{lines}$			1	lines
Reverse stand off voltage	at $I_R = 20 \mu A$	$V_{RWM}$	4			V
Reverse current	at $V_R = 4 V$	$I_R$			20	$\mu A$
Reverse break down voltage	at $I_R = 1 mA$	$V_{BR}$	5	6.1		V
Reverse clamping voltage	at $I_{PP} = 1 A$	$V_C$		7.5	9	V
	at $I_{PP} = I_{PPM} = 30 A$	$V_C$		11.2	14.3	V
Forward clamping voltage	at $I_{PP} = 1 A$	$V_F$		1	1.2	V
	at $I_{PP} = I_{PPM} = 30 A$	$V_F$		4.5		V
Capacitance	at $V_R = 0 V$ ; $f = 1 MHz$	$C_D$		310	450	pF
	at $V_R = 2 V$ ; $f = 1 MHz$	$C_D$		200		pF

## GSOT05

BiAs mode (between pin 3 to 1)

Parameter	Test conditions/remarks	Symbol	Min.	Typ.	Max.	Unit
Protection paths	Number of lines which can be protected	$N_{lines}$			1	lines
Reverse stand off voltage	at $I_R = 10 \mu A$	$V_{RWM}$	5			V
Reverse current	at $V_R = 5 V$	$I_R$			10	$\mu A$
Reverse break down voltage	at $I_R = 1 mA$	$V_{BR}$	6	6.8		V
Reverse clamping voltage	at $I_{PP} = 1 A$	$V_C$		7	8.7	V
	at $I_{PP} = I_{PPM} = 30 A$	$V_C$		12	16	V
Forward clamping voltage	at $I_{PP} = 1 A$	$V_F$		1	1.2	V
	at $I_{PP} = I_{PPM} = 30 A$	$V_F$		4.5		V
Capacitance	at $V_R = 0 V$ ; $f = 1 MHz$	$C_D$		260	350	pF
	at $V_R = 2.5 V$ ; $f = 1 MHz$	$C_D$		150		pF

## GSOT08

BiAs mode (between pin 3 to 1)

Parameter	Test conditions/remarks	Symbol	Min.	Typ.	Max.	Unit
Protection paths	Number of lines which can be protected	$N_{lines}$			1	lines
Reverse stand off voltage	at $I_R = 5 \mu A$	$V_{RWM}$	8			V
Reverse current	at $V_R = 8 V$	$I_R$			5	$\mu A$
Reverse break down voltage	at $I_R = 1 mA$	$V_{BR}$	9	10		V
Reverse clamping voltage	at $I_{PP} = 1 A$	$V_C$		10.7	13	V
	at $I_{PP} = I_{PPM} = 18 A$	$V_C$		15.2	19.2	V
Forward clamping voltage	at $I_{PP} = 1 A$	$V_F$		1	1.2	V
	at $I_{PP} = I_{PPM} = 18 A$	$V_F$		3		V
Capacitance	at $V_R = 0 V$ ; $f = 1 MHz$	$C_D$		160	250	pF
	at $V_R = 4 V$ ; $f = 1 MHz$	$C_D$		80		pF

## GSOT12

BiAs mode (between pin 3 to 1)

Parameter	Test conditions/remarks	Symbol	Min.	Typ.	Max.	Unit
Protection paths	Number of lines which can be protected	$N_{lines}$			1	lines
Reverse stand off voltage	at $I_R = 1 \mu A$	$V_{RWM}$	12			V
Reverse current	at $V_R = 12 V$	$I_R$			1	$\mu A$
Reverse break down voltage	at $I_R = 1 mA$	$V_{BR}$	13.5	15		V
Reverse clamping voltage	at $I_{PP} = 1 A$	$V_C$		15.4	18.7	V
	at $I_{PP} = I_{PPM} = 12 A$	$V_C$		21.2	26	V
Forward clamping voltage	at $I_{PP} = 1 A$	$V_F$		1	1.2	V
	at $I_{PP} = I_{PPM} = 12 A$	$V_F$		2.2		V
Capacitance	at $V_R = 0 V$ ; $f = 1 MHz$	$C_D$		115	150	pF
	at $V_R = 6 V$ ; $f = 1 MHz$	$C_D$		50		pF

## GSOT15

BiAs mode (between pin 3 to 1)

Parameter	Test conditions/remarks	Symbol	Min.	Typ.	Max.	Unit
Protection paths	Number of lines which can be protected	$N_{lines}$			1	lines
Reverse stand off voltage	at $I_R = 1 \mu A$	$V_{RWM}$	15			V
Reverse current	at $V_R = 15 V$	$I_R$			1	$\mu A$
Reverse break down voltage	at $I_R = 1 mA$	$V_{BR}$	16.5	18		V
Reverse clamping voltage	at $I_{PP} = 1 A$	$V_C$		19.4	23.5	V
	at $I_{PP} = I_{PPM} = 8 A$	$V_C$		24.8	28.8	V
Forward clamping voltage	at $I_{PP} = 1 A$	$V_F$		1	1.2	V
	at $I_{PP} = I_{PPM} = 8 A$	$V_F$		1.8		V
Capacitance	at $V_R = 0 V$ ; $f = 1 MHz$	$C_D$		90	120	pF
	at $V_R = 7.5 V$ ; $f = 1 MHz$	$C_D$		35		pF

## GSOT24

BiAs mode (between pin 3 to 1)

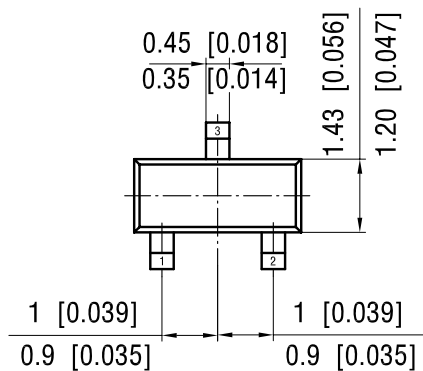
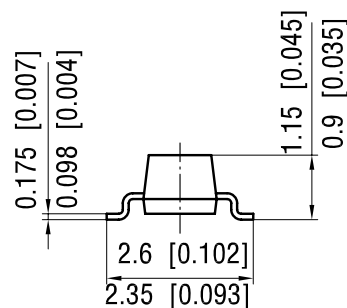
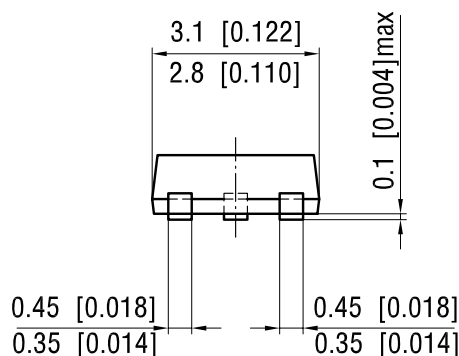
Parameter	Test conditions/remarks	Symbol	Min.	Typ.	Max.	Unit
Protection paths	Number of lines which can be protected	$N_{lines}$			1	lines
Reverse stand off voltage	at $I_R = 1 \mu A$	$V_{RWM}$	24			V
Reverse current	at $V_R = 24 V$	$I_R$			1	$\mu A$
Reverse break down voltage	at $I_R = 1 mA$	$V_{BR}$	27	30		V
Reverse clamping voltage	at $I_{PP} = 1 A$	$V_C$		34	41	V
	at $I_{PP} = I_{PPM} = 5 A$	$V_C$		41	47	V
Forward clamping voltage	at $I_{PP} = 1 A$	$V_F$		1	1.2	V
	at $I_{PP} = I_{PPM} = 5 A$	$V_F$		1.4		V
Capacitance	at $V_R = 0 V$ ; $f = 1 MHz$	$C_D$		65	80	pF
	at $V_R = 12 V$ ; $f = 1 MHz$	$C_D$		20		pF

## GSOT36

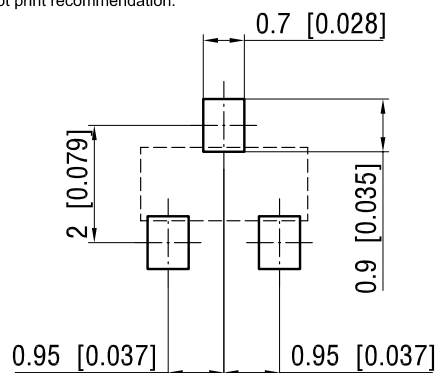
BiAs mode (between pin 3 to 1)

Parameter	Test conditions/remarks	Symbol	Min.	Typ.	Max.	Unit
Protection paths	Number of lines which can be protected	$N_{lines}$			1	lines
Reverse stand off voltage	at $I_R = 1 \mu A$	$V_{RWM}$	36			V
Reverse current	at $V_R = 36 V$	$I_R$			1	$\mu A$
Reverse break down voltage	at $I_R = 1 mA$	$V_{BR}$	39	43		V
Reverse clamping voltage	at $I_{PP} = 1 A$	$V_C$		49	60	V
	at $I_{PP} = I_{PPM} = 3.5 A$	$V_C$		59	71	V
Forward clamping voltage	at $I_{PP} = 1 A$	$V_F$		1	1.2	V
	at $I_{PP} = I_{PPM} = 3.5 A$	$V_F$		1.3		V
Capacitance	at $V_R = 0 V$ ; $f = 1 MHz$	$C_D$		52	65	pF
	at $V_R = 18 V$ ; $f = 1 MHz$	$C_D$		12		pF

## Package Dimensions in millimeters (inches): SOT23



foot print recommendation:



Document no.: 6.541-5014.01-4

Rev. 7 - Date: 08.July.2004

17418

### Ozone Depleting Substances Policy Statement

It is the policy of Vishay Semiconductor GmbH to

1. Meet all present and future national and international statutory requirements.
2. Regularly and continuously improve the performance of our products, processes, distribution and operating systems with respect to their impact on the health and safety of our employees and the public, as well as their impact on the environment.

It is particular concern to control or eliminate releases of those substances into the atmosphere which are known as ozone depleting substances (ODSs).

The Montreal Protocol (1987) and its London Amendments (1990) intend to severely restrict the use of ODSs and forbid their use within the next ten years. Various national and international initiatives are pressing for an earlier ban on these substances.

Vishay Semiconductor GmbH has been able to use its policy of continuous improvements to eliminate the use of ODSs listed in the following documents.

1. Annex A, B and list of transitional substances of the Montreal Protocol and the London Amendments respectively.
2. Class I and II ozone depleting substances in the Clean Air Act Amendments of 1990 by the Environmental Protection Agency (EPA) in the USA.
3. Council Decision 88/540/EEC and 91/690/EEC Annex A, B and C (transitional substances) respectively.

Vishay Semiconductor GmbH can certify that our semiconductors are not manufactured with ozone depleting substances and do not contain such substances.

We reserve the right to make changes to improve technical design  
and may do so without further notice.

Parameters can vary in different applications. All operating parameters must be validated for each customer application by the customer. Should the buyer use Vishay Semiconductors products for any unintended or unauthorized application, the buyer shall indemnify Vishay Semiconductors against all claims, costs, damages, and expenses, arising out of, directly or indirectly, any claim of personal damage, injury or death associated with such unintended or unauthorized use.

Vishay Semiconductor GmbH, P.O.B. 3535, D-74025 Heilbronn, Germany





### Notice

Specifications of the products displayed herein are subject to change without notice. Vishay Intertechnology, Inc., or anyone on its behalf, assumes no responsibility or liability for any errors or inaccuracies.

Information contained herein is intended to provide a product description only. No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document. Except as provided in Vishay's terms and conditions of sale for such products, Vishay assumes no liability whatsoever, and disclaims any express or implied warranty, relating to sale and/or use of Vishay products including liability or warranties relating to fitness for a particular purpose, merchantability, or infringement of any patent, copyright, or other intellectual property right.

The products shown herein are not designed for use in medical, life-saving, or life-sustaining applications. Customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Vishay for any damages resulting from such improper use or sale.